

**Search Notes**

Application/Control No.

10/067,056

Examiner

Kelly L. Jerabek

Applicant(s)/Patent under  
Reexamination

HIRAI, SHINYA

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner
348	222.1	12/12/2005	KJ
	272		
	280		
	289		
	290		
	292		
382	254		
	300	12/22/2005	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE	12/12/2005	KJ
EAST Keyword	12/22/2005	
Tuan Ho	12/20/2005	
Yogesh Aggarwahl	12/20/2005	